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# IRFR210B／IRFU210B <br> 200V N－Channel MOSFET 

## General Description

These N －Channel enhancement mode power field effect transistors are produced using Fairchild＇s proprietary， planar，DMOS technology．
This advanced technology has been especially tailored to minimize on－state resistance，provide superior switching performance，and withstand high energy pulse in the avalanche and commutation mode．These devices are well suited for high efficiency switching DC／DC converters， switch mode power supplies，DC－AC converters for uninterrupted power supply and motor control．

## Features

－ $2.7 \mathrm{~A}, 200 \mathrm{~V}, \mathrm{R}_{\mathrm{DS}(\text { on })}=1.5 \Omega @ \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}$
－Low gate charge（ typical 7.2 nC ）
－Low Crss（typical 6.8 pF）
－Fast switching
－ $100 \%$ avalanche tested
－Improved dv／dt capability


Absolute Maximum Ratings $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless otherwise noted

| Symbol | Parameter | IRFR210B／IRFU210B | Units |
| :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {DSS }}$ | Drain－Source Voltage | 200 | V |
| ${ }_{\text {D }}$ | －Continuous（ $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ ） <br> －Continuous（ $T_{C}=100^{\circ} \mathrm{C}$ ） | 2.7 | A |
|  |  | 1.7 | A |
| $\mathrm{I}_{\text {DM }}$ | Drain Current－Pulsed（Note 1） | 10 | A |
| $\mathrm{V}_{\mathrm{GSS}}$ | Gate－Source Voltage | $\pm 30$ | V |
| $\mathrm{E}_{\text {AS }}$ | Single Pulsed Avalanche Energy（Note 2） | 40 | mJ |
| $\mathrm{I}_{\text {AR }}$ | Avalanche Current（Note 1） | 2.7 | A |
| $\mathrm{E}_{\text {AR }}$ | Repetitive Avalanche Energy（Note 1） | 2.6 | mJ |
| dv／dt | Peak Diode Recovery dv／dt（Note 3） | 5.5 | $\mathrm{V} / \mathrm{ns}$ |
| $\mathrm{P}_{\mathrm{D}}$ | Power Dissipation（ $\left.\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}\right)^{*}$ | 2.5 | W |
|  | Power Dissipation（ $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ ） <br> －Derate above $25^{\circ} \mathrm{C}$ | 26 | W |
|  |  | 0.2 | W／${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {stg }}$ | Operating and Storage Temperature Range | -55 to +150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{L}}$ | Maximum lead temperature for soldering purposes， $1 / 8^{\prime \prime}$ from case for 5 seconds | 300 | ${ }^{\circ} \mathrm{C}$ |

## Thermal Characteristics

| Symbol | Parameter | Typ | Max | Units |
| :--- | :--- | :---: | :---: | :---: |
| $\mathrm{R}_{\theta \mathrm{JC}}$ | Thermal Resistance，Junction－to－Case | -- | 4.9 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{R}_{\theta \mathrm{JA}}$ | Thermal Resistance，Junction－to－Ambient ${ }^{*}$ | -- | 50 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{R}_{\theta \mathrm{JA}}$ | Thermal Resistance，Junction－to－Ambient | -- | 110 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

＊When mounted on the minimum pad size recommended（PCB Mount）

## Electrical Characteristics $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless othemise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Off Characteristics |  |  |  |  |  |  |
| BV ${ }_{\text {DSS }}$ | Drain-Source Breakdown Voltage | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ | 200 | -- | -- | V |
| $\begin{aligned} & \Delta \mathrm{BV}_{\mathrm{DSS}} \\ & / \quad \Delta \mathrm{T}_{\mathrm{J}} \end{aligned}$ | Breakdown Voltage Temperature Coefficient | $\mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$, Referenced to $25^{\circ} \mathrm{C}$ | -- | 0.2 | -- | $\mathrm{V} /{ }^{\circ} \mathrm{C}$ |
| $\mathrm{I}_{\text {DSS }}$ | Zero Gate Voltage Drain Current | $\mathrm{V}_{\mathrm{DS}}=200 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | -- | -- | 10 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{DS}}=160 \mathrm{~V}, \mathrm{~T}_{\mathrm{C}}=125^{\circ} \mathrm{C}$ | -- | -- | 100 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {GSSF }}$ | Gate-Body Leakage Current, Forward | $\mathrm{V}_{\mathrm{GS}}=30 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}$ | -- | -- | 100 | nA |
| IGSSR | Gate-Body Leakage Current, Reverse | $\mathrm{V}_{\mathrm{GS}}=-30 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}$ | -- | -- | -100 | nA |

## On Characteristics

| $\mathrm{V}_{\mathrm{GS}(\mathrm{th})}$ | Gate Threshold Voltage | $\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{\mathrm{GS}}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ | 2.0 | -- | 4.0 | V |
| :--- | :--- | :--- | :---: | :---: | :---: | :---: |
| $\mathrm{R}_{\mathrm{DS}(o n)}$ | Static Drain-Source <br> On-Resistance | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=1.35 \mathrm{~A}$ | -- | 1.16 | 1.5 | $\Omega$ |
| $\mathrm{~g}_{\mathrm{FS}}$ | Forward Transconductance | $\mathrm{V}_{\mathrm{DS}}=40 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=1.35 \mathrm{~A} \quad$ (Note 4) | -- | 2.25 | -- | S |

## Dynamic Characteristics

| $\mathrm{C}_{\text {iss }}$ | Input Capacitance | $\begin{aligned} & \mathrm{V}_{\mathrm{DS}}=25 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \\ & \mathrm{f}=1.0 \mathrm{MHz} \end{aligned}$ | -- | 175 | 225 | pF |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{C}_{\text {oss }}$ | Output Capacitance |  | -- | 30 | 40 | pF |
| $\mathrm{C}_{\text {rss }}$ | Reverse Transfer Capacitance |  | -- | 6.8 | 9.0 | pF |

## Switching Characteristics

| $\mathrm{t}_{\mathrm{d}(\text { on) }}$ | Turn-On Delay Time | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=100 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=3.3 \mathrm{~A}, \\ & \mathrm{R}_{\mathrm{G}}=25 \Omega \end{aligned}$ <br> (Note 4, 5) | -- | 5.2 | 20 | ns |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{r}}$ | Turn-On Rise Time |  | -- | 35 | 80 | ns |
| $\mathrm{t}_{\mathrm{d} \text { (off) }}$ | Turn-Off Delay Time |  | -- | 20 | 50 | ns |
| $\mathrm{t}_{\mathrm{f}}$ | Turn-Off Fall Time |  | -- | 25 | 60 | ns |
| $\mathrm{Q}_{\mathrm{g}}$ | Total Gate Charge | $\begin{aligned} & \mathrm{V}_{\mathrm{DS}}=160 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=3.3 \mathrm{~A}, \\ & \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V} \end{aligned}$ <br> (Note 4, 5) | -- | 7.2 | 9.3 | nC |
| $\mathrm{Q}_{\mathrm{gs}}$ | Gate-Source Charge |  | -- | 1.3 | -- | nC |
| $\mathrm{Q}_{\mathrm{gd}}$ | Gate-Drain Charge |  | -- | 3.5 | -- | nC |

## Drain-Source Diode Characteristics and Maximum Ratings

| $I_{s}$ | Maximum Continuous Drain-Source Diode Forward Current |  |  | -- | -- | 2.7 | A |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\text {SM }}$ | Maximum Pulsed Drain-Source Diode Forward Current |  |  | -- | -- | 10 | A |
| $\mathrm{V}_{\text {SD }}$ | Drain-Source Diode Forward Voltage | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{S}}=2.7 \mathrm{~A}$ |  | -- | -- | 1.5 | V |
| $\mathrm{t}_{\mathrm{rr}}$ | Reverse Recovery Time | $\begin{aligned} & \mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{S}}=3.3 \mathrm{~A}, \\ & \mathrm{dI}_{\mathrm{F}} / \mathrm{dt}=100 \mathrm{~A} / \mathrm{ms} \end{aligned}$ | (Note 4) | -- | 106 | -- | ns |
| $\mathrm{Q}_{\text {rr }}$ | Reverse Recovery Charge |  |  | -- | 0.37 | -- | $\mu \mathrm{C}$ |

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. $\mathrm{L}=8.2 \mathrm{mH}, \mathrm{I}_{\mathrm{AS}}=2.7 \mathrm{~A}, \mathrm{~V}_{\mathrm{DD}}=50 \mathrm{~V}, \mathrm{R}_{\mathrm{G}}=25 \Omega$, Starting $\mathrm{T}_{J}=25^{\circ} \mathrm{C}$
3. $I_{\text {SD }} \leq 3.3 \mathrm{~A}$, di/dt $\leq 300 \mathrm{~A} / \mu \mathrm{s}, \mathrm{V}_{\mathrm{DD}} \leq B V_{\text {DSS }}$, Starting $\mathrm{T}_{J}=25^{\circ} \mathrm{C}$
4. Pulse Test: Pulse width $\leq 300 \mu \mathrm{~s}$, Duty cycle $\leq 2 \%$
5. Essentially independent of operating temperature

## Typical Characteristics



Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage


Figure 5. Capacitance Characteristics


Figure 2. Transfer Characteristics


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature


Figure 6. Gate Charge Characteristics

## Typical Characteristics (Coninued)

Figure 7. Breakdown Voltage Variation vs Temperature


Figure 9. Maximum Safe Operating Area


Figure 8. On-Resistance Variation vs Temperature


Figure 10. Maximum Drain Current vs Case Temperature


Figure 11. Transient Thermal Response Curve





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